# VPC1040CD

# **Design Verification Report**

Initiated by	Max Chen	Job Title	Supervisor	Originate Date	2014/9/20
Reviewed by	Simon Lin	Job Title	Manager	Revision	QQ4-037 Rev.A7
Approved by	Simon Lin	Job Title	Manager	DMR Task Number 版本	T25597-00 A1

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# **Product Information**

DMR Task Number T25597-00

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	Test Unit Information				
Model	VPC1040CD	VPC1040CD			
Description	10.4" Fanless Multifunctional Touch Panel	10.4" Fanless Multifunctional Touch Panel Computer			
PCB version	EBM-BYT A1				
BIOS version	(LPC129I9)LPC/SPC-1009/1209(I) 1024x7683	x18 BIOS rev.1.2 Date:	09/19/2014		
Product phase	DVT				
Produced by	Max Chen	Max Chen			
Core Chipset	Intel® Bay Trail-M/D	Intel® Bay Trail-M/D			
VGA Chipset	Intel® HD Graphics	Intel® HD Graphics			
LAN1 chipset	Intel® I210 Gigabit Network Connection	Connector location	CN1		
LAN2 chipset	Intel® I210 Gigabit Network Connection	Connector location	CN2		
CPU	Onboard Intel® Atom Quad-Core E3845 1.9	Onboard Intel® Atom Quad-Core E3845 1.91GHz with integrated chipset			
Audio	Realtek AL892				
Touch	eGalax Touch 5 Wires resistive				
Test O.S.	Windows 8.1				

### Product image









DMR Task Number T25597-00

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Item	Descriptions	Result
Product Spec Verification	Specification Check	Pass
Function check	I/O Function Test & Check	Pass
LED check	LED indicator check (Power / HDD / LED / Others)	Pass
BIOS & Display Port check	Product ID,Load BIOS default,Display Port Output Test & Check	Pass
Memory Compatibility Test	1.Memtest86 + (3 cycles burn-in) 2.BurnIn Test Pro (15 Min)	Pass
Display Compatibility Test	Check Display Clone & Extend mode	Pass
Performance	CPU, Memory, IDE, SATA, Graphics, LAN,USB	Pass
Power Consumption		Pass
AC Power Margin test	AC power source Upper / Middle / Low limit test	Pass
DC Power Margin test	DC power source Upper / Middle / Low limit test	Pass
Power interruption test	100/200/500/1000ms	Pass
Room temperature Power on/off test	Room temperature / 4000times for system level	Pass
High Temperature Test	70°C /24hrs IEC 60068-2-2 Test:Bb	Pass
Low Temperature Test	-30°C/24hrs IEC 60068-2-1 Test:Ab	Pass
Temperature cycle test	-30°C ~70°C RH95% 6 cycles for system level IEC 60068-2-14 Test:N	Pass

Power on cycle test	-30°C / 1000times for system level IEC 60068-2-1 Test:Ab	Pass
	70°C / 1000times for system level IEC 60068-2-2 Test:Bb	Pass
Storage test	-30℃ 24hrs 70℃/ RH95% 24hrs IEC 60068-2-3 Test:Ca	Pass
Random Vibration Operation	1. PSD: 0.00454G²/Hz, 1.5 Grms 2. operation mode 3. Test Frequency: 5-500Hz 4. Test Axis: X,Y and Z axis 5. 30 minutes per each axis 6. IEC 60068-2-64 Test:Fh 7. Storage: CF or SSD	Pass
Sine Vibration test (Non-operation)	1 Test Acceleration: 2G 2 Test frequency: 5~500 Hz 3 Sweep: 1 Oct/ per one minute. (logarithmic) 4 Test Axis: X,Y and Z axis 5 Test time:10 min. each axis 6 System condition: Non-Operating mode 7. Reference IEC 60068-2-6 Testing procedures	Pass
Package vibration test	1. PSD: 0.026G²/Hz , 2.16 Grms 2. Non-operation mode 3. Test Frequency : 5-500Hz 4. Test Axis : X,Y and Z axis 5. 30 min. per each axis 6. IEC 60068-2-64 Test:Fh	Pass
Bump Test	<ol> <li>Wave form: Half Sine wave</li> <li>Acceleration Rate: 10g for operation mode</li> <li>Duration Time: 11ms</li> <li>No. of Shock: Z axis 1000 times</li> <li>Test Axis: Z axis</li> <li>Operation mode</li> <li>Reference IEC 60068-2-29 Testing procedures         Test Eb: Bump Test     </li> </ol>	Pass
Package drop test	1 One corner , three edges, six faces 2 ISTA 2A, IEC-60068-2-32 Test:Ed	Pass
Misuse Test		Pass
Short Test		Pass
Thermal	1 Max. Loading at Room Temperature & 70℃ for system level 2 Capacitor life time calculation 3 IEC 60068-2-2 Test:Bb	Pass

<sup>\*\*</sup> Notes: Test items and test contents depend on spec.

# **Product Spec Verification**

DMR Task Number T25597-00

	版本	A1
Title	VPC1040CD	<u> </u>
	10.4" Fanless Multifunctional Touch Panel Computer	Check
	Fanless Onboard Intel® Atom Quad-Core E3845 1.91GHz with Integrated Chipset	$\checkmark$
	One 204-pin DDR3L SODIMM Socket Supports Up to 8GB DDR3L 1333 SDRAM	
	1 CF, 2 USB, 1 COM	<b>V</b>
Features	Dual Intel I210IT Gigabit LAN (Co-lay w/ Intel I211AT)	$\checkmark$
1 Gatares	Wide Voltage +12V ~ +26V Input, ErP Power	$\checkmark$
	Backlight Controlled by PWM	V
	IP65 Compliant Front Panel	$\checkmark$
	Timer-Power-On	$\checkmark$
Specifications		
Panel		
LCD size	10.4", 4:3	$\checkmark$
Display Type	XGA TFT	$\checkmark$
Resolution	1024 x 768	$\checkmark$
Pixel pitch	0.0685mm(H) x 0.2055mm(V)	<b>V</b>
Luminance	500 cd/m <sup>2</sup>	<b>V</b>
Contrast ratio	1200	$\checkmark$
Viewing angle	88(U), 88(D), 88(L), 88(R)	<b>V</b>
Response time	25 ms	$\checkmark$
Backlight	LED	V
Touch Type	5 Wires resistive	<b>V</b>
Touch Light transmission	80	$\checkmark$
Touch Interface	USB (EETI)	$\checkmark$
System		
Board	EBM-BYT	$\checkmark$
CPU	Onboard Intel® Atom Quad-Core E3845 1.91GHz with Integrated Chipset	$\checkmark$
System Chipset		
I/O Chip	E/C IT8528E	$\checkmark$
System Memory	One 204-pin DDR3L SODIMM Socket Supports Up to 8GB DDR3L 1333 SDRAM	☑
SSD	One CompactFlash Type I/ II Socket (Support optional InnoDisk CF-SATA)	$\checkmark$
Hard Driver Bay	One 2.5" SATA HDD	$\checkmark$
Watchdog Timer	H/W Reset, 1sec. ~ 65535sec./1sec.step	$\checkmark$
H/W Status Monitor	Monitoring system temperature, voltage, and cooling fan status. Auto throttling control when CPU overheats	$\checkmark$
Expansion	1 x Mini PCIe slot, optional supports mSATA	$\checkmark$
Rear I/O		
Serial Port	1 x RS-232	$\checkmark$
Ethernet	2 x RJ-45	$\checkmark$
VGA	N/A	
HDMI	1 x HDMI	$\checkmark$
Audio port	1 x Line-out	$\checkmark$
USB	1 x USB 3.0, 1 x USB 2.0 (Optional Extra 2 x USB 2.0)	$\checkmark$
Speaker	n/a	
Mouse & K/B	n/a	

Display		
Chipset	Intel Bay Trail SoC Integrated Graphics	$\checkmark$
Display Memory		
Resolution	HDMI 1.4a resolutions up to 1920x1200@ 60 24bpp	<b>V</b>
Dual Display	LVDS + HDMI	$\checkmark$
LVDS		
TV-out		
Audio		
AC97 Codec	Realtek ALC892 supports 5.1-CH Audio	
Audio Interface	Connector: Line out	$\checkmark$
Ethernet		
LAN Chip	Dual Intel I210IT PCI-E Gigabit LAN (Colay w/ Intel I211AT)	$\checkmark$
Ethernet Interface	10/100/1000 Base-Tx Fast Ethernet compatible	$\checkmark$
Mechanical & Environmental		
Color	Front Silver & Rear panel Black	$\checkmark$
Mounting	Wall/Stand/VESA 75 mm x 75 mm	$\checkmark$
System Power Requirement	+12 V ~ +26 V	$\checkmark$
Power Adapter	Input: 100~240 V / 50~60 Hz Output: +12 Vdc / 5 A (60W)	
ACPI	n/a	
Power Type	AT/ATX	$\checkmark$
Operating Temp.	-30 to 70°C	$\checkmark$
Storage Temp.	-30 to 70°C	$\checkmark$
Operating Humidity	5%~90% relative humidity, non-condensing	V
Dimensions	259 x 196 x 41 mm	$\checkmark$
Weight	2.11 Kgs	$\checkmark$

# Function check

DMR Task Number

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	版本	A1
	OS	Note
	Windows XP+SP3	
$\overline{m{ec{ec}}}$	Windows 8.1	
	Fedora Core 12 ( Linux )	

Subject	Test Item	Pass	Fail	Note
Install OS	Install OS	✓		
	Chipset Driver	✓		
	Video Driver	✓		
nstall M/B Driver	Audio Driver	✓		
	LAN Driver	✓		
	Touch Driver	✓		
Bid Visit	Check Location I/O	✓		
Screen Printing Verification	Check Device Number by OS	✓		
	0%	<b>√</b>		
	20%	<b>√</b>		
external Display Brightness	40%	<b>√</b>		
Graphics Driver)	60%	✓		
	100%	✓		
	800*600 32Bit	NA		
	1024*768 16Bit	NA NA		
	1024*768 32Bit	<b>√</b>		
	1280*1024 32Bit	NA		
	1600*1200 32Bit	NA NA		
	1920*1200 32Bit	NA		
Display Setting	DVI -1	NA		
Graphics Driver)	DVI -2	NA		
	HDMI	<i>√</i>		
	CRT	NA		
	Display	NA		
	TV-Out AV port	NA		
	TV-Out S-Terminal	NA		
	Video Obstacle Course	<i>√</i>		
	Geometry and Distortion	<b>√</b>		
	Sharpness and Resolution	<b>√</b>		
Display Test : DMW-NEW	Screen Pixel and Resolution	<b>√</b>		
	Color and Gray-scale	<b>√</b>		
	Misscellaneous Effects	✓		
	HDMI Audio Test	✓		
	Display Audio Test	NA		
	Line Out Test (Amplifier Speaker discontinue)	√ ·		
audio Function	Line Out Nosie Check (No any voice output)	✓		
	MIC In Test	NA		
	Sound Record Test	NA		
	Player CD Audio (Left /Right speaker check)	<b>√</b>		

	Amplifier Speaker Spec Check	NA	
	Amplifier Speaker Volume control (Left /Right speaker check)	NA	
	Amplifier Speaker Noise Check (No any voice output)	14/ (	
Audio Function		NA	
(Amplifier Speaker)	Amplifier Speaker 30% Volume Test	NA	Must be no noise
	Amplifier Speaker 50% Volume Test	NA	Must be no noise
	Amplifier Speaker 70% Volume Test	NA	Must be no noise
	Amplifier Speaker 100% Volume Test	NA	Must be no noise
	Amplifier Speaker % Volume Quality Check	NA	
	Network Setting	✓	
LAN Function	Transmission Data	✓	
	Internet Test	✓	
	Wake Up By S5	✓	
	Touch function test	✓	
Touch function	Wake up from S3	✓	
	Wake up from USB Keyboard	✓	
ACPI function (S3)	Wake up from USB Mouse	✓	
	Wake up from Power Button	✓	
IR Function	Transmission Data	NA	
HODA Interfere Device	Check USB Keyboard	✓	
USB1 Interface Device	Check USB Mouse	✓	
LIODO Interfere Design	Check USB Keyboard	✓	
USB2 Interface Device	Check USB Mouse	✓	
COM Part4 Interface Parties	Check Modem	✓	
COM Port1 Interface Device	Modem Ring By S5	✓	
LPT Port Interface Device	Check Printer	NA	
Warm boot test	Software reset (Passmark Rebooter test)	✓	Under Win8.1+SP1+drivers test at room temperature for 100 duration cycles, Time Out Before Reboot:10- 20secs
RTC Timer Wake up from S5	Check DOS Mode & Windows Mode	✓	

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	版本	A1
	OS	Note
	Windows XP+SP3	
abla	Windows 8.1	
	Fedora Core 12 ( Linux )	

#### 7.8.1 Colours of indicator lights

The colours of indicator lights and their meanings shall comply with Table 2.

NOTE IEC 60601-1-8 contains specific requirement for the colour, flashing frequency and DUTY CYCLE of alarm indicator lights.

Dot-matrix and other alphanumeric displays are not considered to be indicator lights.

Table 2 - Colours of indicator lights and their meaning **for ME EQUIPMENT** 

Colour	Meaning
Red	Warning – immediate response by the OPERATOR is required
Yellow	Caution – prompt response by the OPERATOR is required
Green	Ready for use
Any other colour	Meaning other than that of red, yellow or green

Subject	Test Item	Pass	Fail	Note
	Power on LED color check	✓		
Power LED indicator (LED indicator must be in the darkroom	Power LED Dark for system off	✓		Can't have Micro-Light lamp
confirmation)	Power LED Light for system turn on	✓		
	Power LED Flash for standby with ATX power	✓		
HDD LED indicator	HDD LED Flash for HDD active Read / Write	✓		
(LED indicator must be in the darkroom confirmation)	HDD LED Dark for HDD no active	<b>√</b>		Can't have Micro-Light lamp
	Data Rate , Off => 10Mbits/sec	✓		
	Data Rate , Green => 100Mbits/sec	✓		
Ethomat I ED indicator	Data Rate , Orange => 1000Mbits/sec	✓		
Ethernet LED indicator	Link / ACT , Off => not established	✓		
	Link / ACT , Yellow On => established	✓		
	Link / ACT , Yellow Blinking => activity	✓		

# BIOS & Display Port check

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BIOS Version (LPC129I9)LPC/SPC-1009/1209(I) 1024x768x18 BIOS rev.1.2
Date:09/19/2014

Subject	Test Item	Pass	Fail	Note
BIOS Boot System Product ID	(LPC129I9)LPC/SPC-1009/1209(I) 1024x768x18 BIOS rev.1.2 Date:09/19/2014	✓		
CPU Temperature	CPU BIOS Data / Meter Measure Data	✓		40 °C / 43 °C
System Temperature	System BIOS Data / Meter Measure Data	✓		38 ℃ / 40 ℃
HDMI Audio	Default Enable	✓		
Backlight PWM Duty Cycle	00% ~ 100%	✓		
	Panel Resolution	✓		1024x768 18
Load BIOS default (For System Product Setting)	Graphics Memory Size	✓		256
(For System Froduct Setting)	Boot Type	✓		
	VBIOS Default	✓		
	LVDS	✓		
	CRT	NA		
	DVI -1	NA		
Single Display Port Output (BIOS / DOS TXT Mode)	DVI -2	NA		
(BIOS / DOS TXT Mode)	HDMI	✓		
	Display port	NA		
	TV-Out AV port	NA		
	TV-Out S-Terminal	NA		
	VBIOS Default	NA		
	LVDS+CRT	NA		
	LVDS+HDMI	✓		Only have HDMI on DOS Mode
	LVDS+DVI1	NA		
	LVDS+DVI2	NA		
	CRT+LVDS	NA		
	CRT+HDMI	NA		
Multi Display Port Output	CRT+DVI1	NA		
(BIOS / DOS TXT Mode)	CRT+DVI2	NA		
	DVI1+LVDS	NA		
	DVI1+HDMI	NA		
	DVI1+CRT	NA		
	DVI1+DVI2	NA		
	DVI2+LVDS	NA		
	DVI2+HDMI	NA		
	DVI2+CRT	NA		
	DVI2+DVI1	NA		

# Memory Compatibility Test

DMR Task Number T25597-00

-				版本	A1
Test Engineer	Max Chen Da	ate	2014/8/23	Result	Pass
Test Configuration					
Model name	VPC1040CD				
Description	10.4" Fanless Multifu	unctional Touch Panel Computer			
Hardware PCB version	A1				
BIOS version	LPC129I9.BIN				
CPU Type	Intel® Atom™ Proces	ssor E3845 (2M Cache, 1.91 GHz)			
Memory type and size	as below				
Backplane	N/A				
Power(or Adapter)	FSP FSP060-DBAE1	1 12V/5A 60W Adapter			
HDD Model/Spec	PLEXTOR PW64G-5	5S 64GB 2.5" SSD			
CD-ROM Model/Spec	N/A				
Chipset	Intel® Bay Trail-M/D		Driver Ver	10.0.14	
VGA	Intel® HD Graphics		Driver Ver	10.18.10.3925	
LAN	Intel® Ethernet Conti	roller I210-iT	Driver Ver	12.8.26.0 (18.7)	
Audio	Realtek ALC892		Driver Ver	6.0.1.7083(R273)	
Touch	eGalax Touch		Driver Ver	5.12.0.10220	
Other	N/A		Driver Ver	N/A	
Test program	Memtest86 + (3 cycle	es burn-in)	Version	V5.1	
ACPI Test	S3 / S4		Version	N/A	
Backplane	BurnInTest Standard		Version	V7.0	
Produced by	Max Chen				

- \* Blue item need to burn-in 12 hours
- \* All Test item need to test ACPI status

### SODIMM DDR3L

Brand	Size	Speed	Туре	ECC	Vendor PN	S/N	Memory	Result	Note/Issue ID
Transcend	4GB	DDR3L 1600	SODIMM DDR3	N	TS512MSK64W6H-I	B33407-0063	SEC 404 BYK0 K4B4G0846D	Pass	
	2GB	DDR3L 1600	SODIMM DDR3	N	M2A11309050010006WE	M3S0-2GHJCLPC	hynix H5TC2G83EFR	Pass	
InnoDisk	4GB	DDR3L 1600	SODIMM DDR3	N	MOS11309030030002WA	M3S0-4GHSCLPC	hynix H5TC4G83AFR	Pass	
	8GB	DDR3L 1600	SODIMM DDR3	N	MOS11311200040004WA	M3S0-8GHSDLPC	hynix H5TC4G83AFR	Pass	

# **Display Compatibility Check**

DMR Task Number T25597-00

				版	<u> </u>	<b>A</b> 1
Test Engineer	Max Chen	Date	2014/8/23	Pass	Fail	Limit.
Test Configuration				37	0	0
Item		Description		Description		
Model name	VPC1040CD			DVT		
CPU type	Intel® Atom™ Processor	E3845 (2M Cache, 1.91 G	Hz)			
BIOS type	AMI EFI	BIOS version	LPC129I9.BIN			
DRAM type	Transcend DDR3L 1600	4GB TS512MSK64W6H-I				
Power type	FSP FSP060-DBAE1 12V	//5A 60W Adapter				
HDD type	PLEXTOR PW64G-5S 64	GB 2.5" SSD		Master/Slave		
LAN Driver	Intel® Ethernet Controller	I210-iT		Version	12.8.26.0 (18.7	7)
VGA Driver	Intel® HD Graphics			Version 10.18.10.3925		
Audio Driver	Realtek ALC892			Version	6.0.1.7083(R2	73)
OS type	Windows 8.1			SP version	N/A	
Test program	BurnInTest Standard			Version	V7.0	
Produced by	Max Chen					

LCD Display Full Screen Check (Clone & Extend Mode Check)

Brand and Model	Signal type	Test Item		Result	Note/Issue ID
		System power on in	nitial test	Pass	
			800x600	Pass	
Acer S235HL	Digital		1024x768	Pass	
Acei 3233FL	(HDMI)	Resolution	1280x1024	Pass	
			1600x1200	Pass	
			Max Resolution	Pass	1920 x 1080 (Extend Mode)
		System power on in	System power on initial test		
			800x600	Pass	
ASUS VK246	Digital		1024x768	Pass	
A303 VK240	(HDMI)	Resolution	1280x1024	Pass	
			1600x1200	Pass	
			Max Resolution	Pass	1920 x 1080 (Extend Mode)
		System power on in	nitial test	Pass	
			800x600	Pass	
acer A243WA	Digital		1024x768	Pass	
acei A243VVA	(HDMI)	Resolution	1280x1024	Pass	
			1600x1200	Pass	
			Max Resolution	Pass	1920 x 1200 (Extend Mode)

		System power on initial test		Pass	
			800x600	Pass	
DELL U2410	Digital		1024x768	Pass	
DELE 02410	(HDMI)	Resolution	1280x1024	Pass	
			1600x1200	Pass	
			Max Resolution	Pass	1920 x 1200 (Extend Mode)
		System power on initial test		Pass	
			800x600	Pass	
DELL 3008WFP	Digital		1024x768	Pass	
DELL 3006WFP	(HDMI)	Resolution	1280x1024	Pass	
			1600x1200	Pass	
			Max Resolution	Pass	1920 x 1080 (Extend Mode)

Driver Feature					
Item	Resolution	Comment	Test Stage	Result	Note/Issue ID
Rotation	Win 8.1		DVT	Pass	
Color Correction	Win 8.1		DVT	Pass	
Dual display (clone)	Win 8.1		DVT	Pass	
Dual display (Extend)	Win 8.1		DVT	Pass	
Extended mode	LVDS primary		DVT	Pass	
LVDS + HDMI	HDMI primary		DVT	Pass	
2 Display Full Screen Test	LVDS + HDMI		DVT	Pass	

# Performance Benchmark

DMR Task Number

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				版本	ΑΊ		
Test Engineer	Max Chen	Date	2014/8/7	Result	Pass		
<b>DUT Testing Co</b>	nfiguration Definition	DUT Testing Configuration					
CPU type /ID	Highest CPU Spec.	Intel® Atom™ F	Processor E3845 (2M Ca	ache, 1.91 GHz)			
Memory type	Max. Memory Size	Transcend TS5	12MSK64W6H DDR3L	1600 4GB			
VGA	AGP/PCI/PCI-E VGA interface (Chipset)	Intel® HD Grapl	hics				
VGA Memory	Max. shared memory of 256MB or On board memory size	256MB					
HDD type	IDE or SATA/SATAII HDD	PLEXTOR PW6	64G-5S 64GB 2.5" SSD				
ODD type	IDE or SATA/SATAII DVD-ROM	NA					
	1. INF driver	10.0.14					
	2. RAID driver	N/A					
	3. VGA driver	10.18.10.3925					
Installation Driver	4. Audio driver	6.0.1.7083(R273)					
	5. USB2.0 driver	N/A					
	6. LAN driver (Chipset)	12.8.26.0 (18.7)					
	7. Direct X	Direct X11					
O.S.	Windows 8.1 ,1024 × 768 in 32bit colors						

System Performance						
Item	Comment / (unit)	Software	E3845			
	CPU Arithmetic Benchmark-ALU / (GIPS)		23.34			
	CPU Arithmetic Benchmark-FPU / (GFLOPS)		18			
CPU	Procesor Multi-Media Int (Mpixel/s)	SiSoftware Sandra	37.45			
CPU	Procesor Multi-Media Float (Mpixel/s)	2011.5.17.47	26.71			
	Multi-Core Efficiency-Inter-Core Bandwidth (GB/sec)		1.24			
	Multi-Core Efficiency-Inter-Core Latency (ns) (smaller is better)		155.6			
	Memory Bandwidth-Int Buff'd (GB/sec)		5.25			
Memory	Memory Bandwidth Float Buff'd (GB/sec)	SiSoftware Sandra	5.23			
Memory	Memory Latency (ns) (smaller is better)	2011.5.17.47	127.1			
	Speed Factor (smaller is better)		81			
	Transfer Rate / Average (MB/s)		150.4			
Dick (SATA)	Access Time (ms)	HD Tune Pro 4.6	0.109			
Disk (SATA)	Burst Time (MB/s)	TID TUILE FIG 4.6	156.5			
	CPU Usage (%)		9.9			
Graphics	3DMark / (3DMarks)	3DMark 11 / build 105	P41			
	Average (Mbps) (all pairs)		513.89			
LAN1	Maximum (Mbps) (all pairs)	IxChariot 6.7	727.28			
	Minimum (Mbps) (all pairs)		266.669			

PCMark 2005	Score	Score
Score	4393	
CPU	3907	
Memory	3041	
Graphic	1387	
HDD	11252	

Passmark Performance Test Pro (v8.0 Build 1026)	Score	Score
CPU Mark	1173.3	
2D Graphic Mark	163.6	
3D Graphic Mark	152.7	
Memory Mark	481.6	
Disk Mark	466.8	
Passmark Rating(Complete Result)	547.5	

CrystalMark 2008 Test (0.8.96.200)	Score	Score
Mark	114647	
ALU	29049	
FPU	17787	
МЕМ	41217	
HDD	13953	
GDI	9280	
D2D	3361	

## AC Power margin Test

DMR Task Number

版本

T25597-00

Α1

Test Engineer	Max Chen	Date	2014/8/22	Result	Pass		
Test Configuration							
Model name	VPC1040CD						
Description	10.4" Fanless Multi	functional Touch Pa	anel Computer				
Hardware PCB version	EBM-BYT A1						
BIOS version	LPC129I9.BIN						
CPU Type	Intel® Atom™ Proc	essor E3845 (2M Ca	ache, 1.91 GHz)				
Memory type and size	Transcend DDR3L	1600 4GB TS512MS	SK64W6H-I				
Backplane	N/A						
Power(or Adapter)	FSP FSP060-DBAE1 12V/5A 60W Adapter						
HDD Model/Spec	PLEXTOR PW64G-	5S 64GB 2.5" SSD					
CD-ROM Model/Spec	N/A						

### **AC Power margin Test**

Item	Voltage	Voltage						
AC power low limit	90V / 60Hz	100V	-10%	DVT	Pass			
AC power low limit	90V / 50Hz	100V	-10%	DVT	Pass			
AC power middle value	180V / 60Hz	(upper limit +	low limit) /2	DVT	Pass			
AC power middle value	180V / 50Hz	(upper limit +	low limit) /2	DVT	Pass			
AC power upper limit	264V / 60Hz	240V	+10%	DVT	Pass			
AC power upper lifflit	264V / 50Hz	240V	+10%	DVT	Pass			

- 1. Adjust AC power source to specified voltage with Upper/Low limit.
- ON/OFF test 10 cycles (1 minute ON and 1 minute OFF constitute 1 cycle)
   Turn on the system and startup into the OS Windows 8.1 professional and make the product to maximum loaded condition with running Pass Mark Burn in test program 7.0

## DC Power margin Test

**DMR Task Number** 

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T25597-00 Α1

Test Engineer	Max Chen	Date	2014/8/22	Result	Pass
Test Configuration					
Model name	VPC1040CD				
Description	10.4" Fanless Mul	Itifunctional Tou	ch Panel Computer		
Hardware PCB version	EBM-BYT A1				
BIOS version	LPC129I9.BIN				
CPU Type	Intel® Atom™ Pro	cessor E3845 (2	M Cache, 1.91 GHz)		
Memory type and size	Transcend DDR3	L 1600 4GB TS5	12MSK64W6H-I		
Backplane	N/A				
Power(or Adapter)	DC power source				
HDD Model/Spec	PLEXTOR PW64G	6-5S 64GB 2.5" S	SD		
CD-ROM Model/Spec	N/A				

### **Power margin Test**

Item	Voltage	Voltage						
DC power upper limit	27.30V	26V	+5%	DVT	Pass			
DC power middle value	19V	(upper limit + low limit) /2		DVT	Pass			
DC power low limit	11.40V	12V	-5%	DVT	Pass			

- Adjust DC power source to specified voltage with Upper/Low limit.
   ON/OFF test 10 cycles (1 minute ON and 1 minute OFF constitute 1 cycle)
   Turn on the system and startup into the OS Windows 8.1 and make the product to maximum loaded condition with running Pass Mark Burn in test program 7.0

## **Power Consumption**

**DMR Task Number** 

T25597-00

				版本	: A1
Test Engineer	Max Chen	Date	2014/8/22	Result	Pass
Test Configuration					
Item				Description	
Model name	VPC1040CD			DVT	
BIOS version	LPC129I9.BIN				
Hardware PCB version	EBM-BYT A1				
CPU type	Intel® Atom™ Processor E3845 (2	M Cache, 1.91	GHz)		
DRAM type	Transcend DDR3L 1600 4GB TS5	512MSK64W6H	-I		
HDD/ODD Model/Spec	PLEXTOR PW64G-5S 64GB 2.5"	SSD		Master/Slave	
Chipset	Intel® Bay Trail-M/D	Driver Ver	10.0.14		
VGA	Intel® HD Graphics	Driver Ver	10.18.10.3925		
LAN	Intel® Ethernet Controller I210-IT	Driver Ver	12.8.26.0 (18.7)		
Audio	Realtek ALC892	Driver Ver	6.0.1.7083(R273)		
Touch	eGalax Touch	Driver Ver	5.12.0.10220		
other	N/A	Driver Ver	N/A		
Power(or Adapter)	DC power source				
OS type	Windows 8.1	SP version	N/A		
Test program	3D Mark	Version	V11		
Backplane	N/A	Version	N/A		
Produced by	Max			<del>.</del>	

Testing Software (MAX. load )

- MaxPower and 3D graphic both supported: Maxpower + 3DMark 11
- 2 MaxPower cannot support but K power suported: K power\*4 + 3DMark 11
- 3 K Power suported but 3D graphic cannot suported: K power
- 4 MaxPower and K power both cannot supported: Hot CPU pro 4.22.

\*\*If LAN is on board function, all LAN ports have to connect to a switch HUB through CAT5e LAN cable, but don't need to do data transfer, or through a cross over cable connect two LAN ports is acceptable

#### Condition

Power on - Boot sequency: Measure the maximum current value of between system power on and boot-up to O.S.

 $\textbf{DOS Idle mode:} \ \textit{Measure the current value when system in DOS mode and without running any program}$ 

Win. Idle mode: Measure the current value when system in windows mode and without running any program

Max. load: Measure the maximum current value which system under maximum load (CPU: Top speed ,RAM & Graphic: Full loading)

Condition		Power Consumption (A or mA)					
Voltage/Condition	Power on - Boot procedure	ldle mode	S3	<b>S</b> 5	Max. load	Testing Software	Note/Issue ID
+12V	1.99	1.73	0.13	9 0.13	2.3577	2	
Total	23.88	20.76	1.67	1.50	28.29	W	
+19V	1.2975	1.10	0.10	0.09	1.495	2	
Total	24.65	20.90	1.96	3 1.77	28.41	W	
+24V	1.07	0.92	0.09	0.10	1.2439	2	
Total	25.68	22.08	2.16	2.40	29.85	W	

Condition						
		Voltage Condition		Current (A)	Watt (W)	
Intel® Atom™ Processor E3845 (2M Cache, 1.91 GHz)	V	12V	12	0.0143	0.17	
	$\checkmark$	19V	19	0.0151	0.29	
330.0,	$\checkmark$	24V	24	0.0156	0.37	

## **Power interruption Test**

**DMR Task Number** 

T25597-00

**Test Engineer** 2014/8/23 **Max Chen** Date Result **Test Configuration** Model name VPC1040CD Description 10.4" Fanless Multifunctional Touch Panel Computer Hardware PCB version EBM-BYT A1 LPC12919.BIN **BIOS** version Intel® Atom™ Processor E3845 (2M Cache, 1.91 GHz) **CPU Type** Transcend DDR3L 1600 4GB TS512MSK64W6H-I Memory type and size Backplane FSP FSP060-DBAE1 12V/5A 60W Adapter Power(or Adapter) HDD Model/Spec PLEXTOR PW64G-5S 64GB 2.5" SSD CD-ROM Model/Spec

### **Power interruption test**

Environment : 25°C ± 2°C ambient Humidity : 50 ± 10% RH Test Condition:

Test time: 10 times

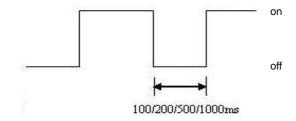
Interval time 100ms/200ms/500ms/1000ms

1 Input the AC voltage Procedure:

2 system boot up

3 Apply switching main power switch with the specified conditions.

(In case of the products equipped with the voltage-switch unit, installed them)



Judgment Criteria:

- 1 There must be no danger of fire.
- 2 It must not catch fire or produce smoke.
- 3 There should be no abnormal phenomenon (ex. auto-boot up)
- 4. There should be no abnormalities affecting the product's functions and performance

### **Power interruption Test**

Item	Adapter	interval time	Mode	Test Stage	Result	Note/Issue ID
Power interruption Test	FSP060-DBAE1	100ms	ATX	DVT	Pass	
	FSP060-DBAE1	200ms	ATX	DVT	Pass	
	FSP060-DBAE1	500ms	ATX	DVT	Pass	
	FSP060-DBAE1	1000ms	ATX	DVT	Pass	

## **Room Temp Power On/Off Test**

**DMR Task Number** 

T25597-00

2014/8/24 **Test Engineer Max Chen** Date Result Model name VPC1040CD Description 10.4" Fanless Multifunctional Touch Panel Computer Hardware PCB version EBM-BYT A1 LPC129I9.BIN **BIOS** version Intel® Atom™ Processor E3845 (2M Cache, 1.91 GHz) **CPU Type** Transcend DDR3L 1600 4GB TS512MSK64W6H-I Memory type and size N/A Backplane Power(or Adapter) FSP FSP060-DBAE1 12V/5A 60W Adapter PLEXTOR PW64G-5S 64GB 2.5" SSD HDD Model/Spec CD-ROM Model/Spec

#### Room Temp Power On/Off Test

Test Condition : Cond

1 Test temperature : Room temperature

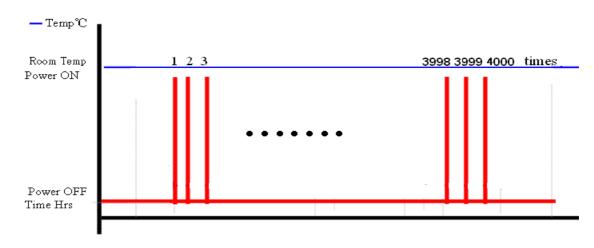
2 Number of test : 4000 times 3 Test software : MS DOS

4 Step: A) System power on, record the count number then system power off

B) After 1 minutes, system power on again.C) Recycle step A and B for 4000 times.

5 Test environment curve :

#### Test environment curve :



Performance criteria :

- $1 \ \hbox{All system functions must} \ be \ checked \ with \ appropriate \ testing \ programs \ and \ should \ pass \ the \ inspection.$
- 2 There should be no abnormalities, which couldn't affect the product specified functions and performances.

Test result: There is

There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.

Temperature	Power mode				
Room temperature	AT ATX				
Result	N/A	Pass			





## **High Temperature Operation Test**

DMR Task Number

T25597-00

					版 <del>本</del> AT	
Test Engineer	Max	Date	2014/8/26	Result	Pass	
Model name		VPC1040CD				
Description 10.4" Fanless Multifunctional Touch Panel Computer						
Hardware PCB version	n	EBM-BYT A1				
BIOS version		LPC129I9.BIN				
CPU Type		Intel® Atom™ F	Processor E3845 (2M Cache, 1.91 GHz)			
Memory type and size		Transcend DDI	R3L 1600 4GB TS512MSK64W6H-I			
Backplane		N/A				
Power(or Adapter)		FSP FSP060-DE	BAE1 12V/5A 60W Adapter			
HDD Model/Spec		PLEXTOR PW6	4G-5S 64GB 2.5" SSD			
CD-ROM Model/Spec		N/A				

High Temperature Operation Test

Test Standard : Reference IEC60068-2-2 Testing procedures

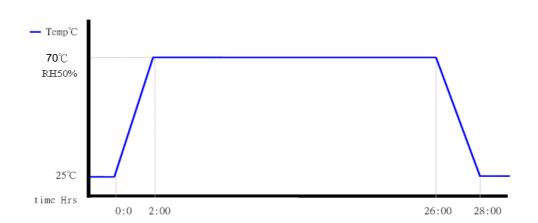
Test Bb : Dry Heat Test

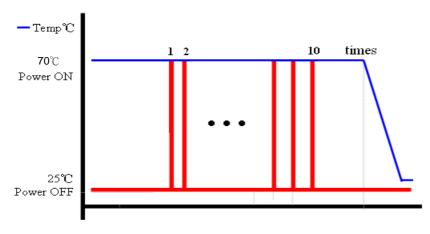
Test Condition : 1 Test Temperature :  $70^{\circ}$ C for system level

2 Test Time: 24 hours

3 Test software: PassMark Burn in test 7.0 in Win 8.1

4 Executing on/off test 10 times after running burn in test 24 hours





Test equipment :

Programmable temperature & humidity chamber

use chamber				V
Model:	Ten Billion FX1004	THS-D4T-150	THS-D4T-150+LN2	KSON THS-A4T-100
Date of calibration :	2013/12/20	2014/6/24	2014/6/24	2013/12/20

Performance criteria: 1 All system functions must be checked with appropriate testing programs and should pass the inspection.

2 There should be no abnormalities, which couldn't affect the product specified functions and performances.

Test result : There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.





## Low Temperature Operation Test

DMR Task Number

T25597-00

版本	A1

Test Engineer	Max	Date	2014/8/27	Result	Pass	
Model name		VPC1040CD				
Description		10.4" Fanless Multifunctional Touch Panel Computer				
Hardware PCB version	า	EBM-BYT A1				
BIOS version		LPC129I9.BIN				
CPU Type		Intel® Atom™ Processor E3845 (2M Cache, 1.91 GHz)				
Memory type and size		Transcend DDR3L 160	0 4GB TS512MSK64W6H-I			
Backplane		N/A				
Power(or Adapter)		FSP FSP060-DBAE1 12V/5A 60W Adapter				
HDD Model/Spec		PLEXTOR PW64G-5S 64GB 2.5" SSD				
CD-ROM Model/Spec		N/A				

Low Temperature Operation Test

Test Standard : Reference IEC60068-2-1 Testing procedures

Test Ab : Cold Test

Test Condition : 1 Test Temperature : -30 $^{\circ}$ C

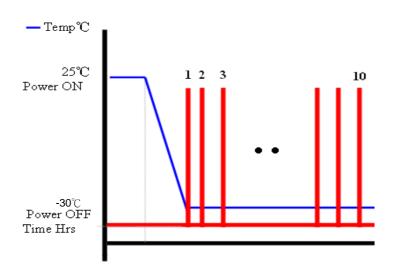
2 Test Time: 24 hours

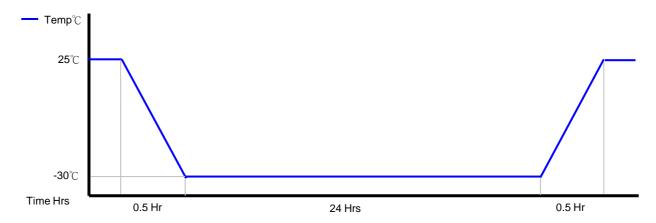
3 Test software: PassMark Burn in test 7.0 in Win 8.1

Test procedure : 1 Power on at -30°C into Win 8.1 by manually and check device manager list, there are should be no "!" or "?" mark display

2 Peripheral check: 10 times

3 After peripheral chek is finish, keep lower chamber temperature at -30  $^\circ\!\mathbb{C}$  and running test program.





Test equipment : Programmable temperature & humidity chamber

use chamber				V
Model:	Ten Billion FX1004	THS-D4T-150	THS-D4T-150+LN2	KSON THS-A4T-100
Date of calibration :	2013/12/20	2014/6/24	2014/6/24	2013/12/20

Performance criteria: 1 All system functions must be checked with appropriate testing programs and should pass the inspection.

2 There should be no abnormalities, which couldn't affect the product specified functions and performances.

Test result : There are should be no "!" or "?" mark display at device manager

There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.





Note: 1.Panel's backlight obvious brighten on -30  $^{\circ}\mathbb{C}$  2.System response lag on -30  $^{\circ}\mathbb{C}$ 

## Temperature cycle test

**DMR Task Number** 

T25597-00

				// //	Λ1
Test Engineer	Max	Date	2014/8/28	Result	Pass
Test Configuration					
Model name	VPC1040CD				
Description	10.4" Fanless M	ultifunctional Touch F	Panel Computer		
Hardware PCB version	EBM-BYT A1				
BIOS version	LPC129I9.BIN				
CPU Type	Intel® Atom™ P	rocessor E3845 (2M C	ache, 1.91 GHz)		
Memory type and size	Transcend DDR	3L 1600 4GB TS512M	SK64W6H-I		
Backplane	N/A				
Power(or Adapter)	FSP FSP060-DB	AE1 12V/5A 60W Adap	oter		
HDD Model/Spec	PLEXTOR PW64	G-5S 64GB 2.5" SSD			
CD-ROM Model/Spec	N/A				

Temperature cycle test

Test Standard : Reference IEC60068-2-14 Testing procedures

Test N : Change of temperature test

Test Condition : 1 Test Temperature : High temperature 70°C RH95% / Low temperature -30°C

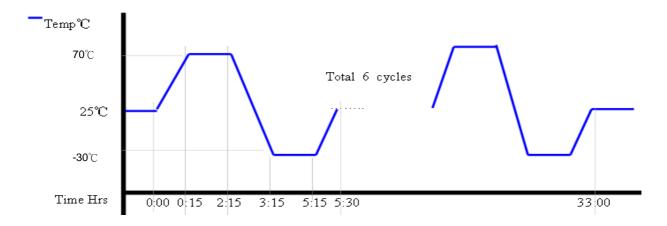
2 Test dwell Time: 2 hours

3 Temperature slope : heating 1 hour, cooling 1 hour

4 Test cycle: 6 cycles

5 Test software: PassMark Burn in test 7.0 in Win 8.1

6 Test environment curve



### Test equipment :

### Programmable temperature & humidity chamber

use chamber				V
Model:	Ten Billion FX1004	THS-D4T-150	THS-D4T-150+LN2	KSON THS-A4T-100
Date of calibration :	2013/12/20	2014/6/24	2014/6/24	2013/12/20

Performance criteria: 1 All system functions must be checked with appropriate testing programs and should pass the inspection.

2 There should be no abnormalities, which couldn't affect the product specified functions and performances.

Test result : There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.

### Test picture :







Note: 1.Panel's backlight obvious brighten on -30  $^{\circ}\! \text{C}$ 

## Power on cycle test

DMR Task Number

T25597-00

版本 A1
-------

Test Engineer	Max Chen	Date	2014/8/26~2014/08/27	-30°C Result	Pass
Test Configuration				70°C Result	Pass
Model name	VPC1040CD				
Description	10.4" Fanless Multi	functional Touch	n Panel Computer		
Hardware PCB version	EBM-BYT A1				
BIOS version	LPC129I9.BIN				
CPU Type	Intel® Atom™ Proc	essor E3845 (2M	Cache, 1.91 GHz)		
Memory type and size	Transcend DDR3L	1600 4GB TS512	MSK64W6H-I		
Backplane	N/A				
Power(or Adapter)	FSP FSP060-DBAE	1 12V/5A 60W Ad	lapter		
HDD Model/Spec	PLEXTOR PW64G-5	5S 64GB 2.5" SSI	D		
CD-ROM Model/Spec	N/A				

Power On/Off Test

Test Standard : Reference IEC60068-2-2 Testing procedures Test Bb : Dry Heat test

Reference IEC60068-2-1 Testing procedures Test Ab: Cold test

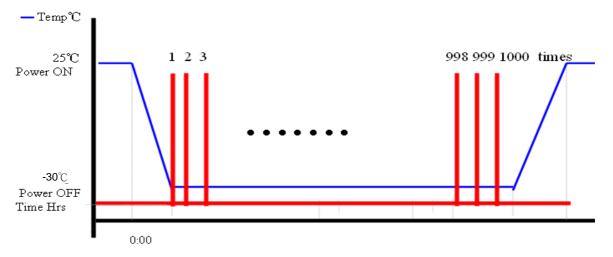
Test Condition : Condition

1 Test temperature : -30°C 2 Number of test : 1000 times 3 Test software : MS DOS

4 Step : A) System power on, record the count number then system power off

B) After 1 minutes, system power on again.C) Recycle step A and B for 1000 times.

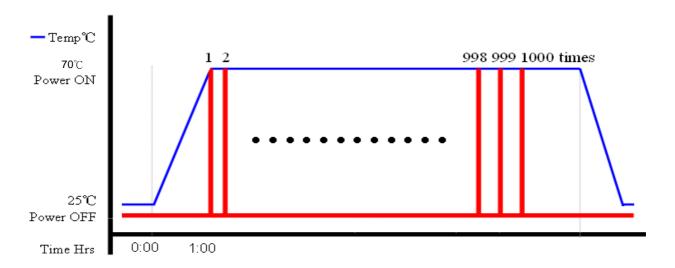
5 Test environment curve :



#### Condition II

1 Test temperature : 70°C 2 Number of test : 1000 times 3 Test software : MS DOS

- 4 Step: A) System power on, record the count number then system power off
  - B) After 1 minute, system power on again.
  - C) Recycle step A and B for 1000 times.
- 5 Test environment curve :



Test equipment:

Programmable temperature & humidity chamber

use chamber		V		
Model:	Ten Billion FX1004	THS-D4T-150	THS-D4T-150+LN2	KSON THS-A4T-100
Date of cali	2013/12/20	2014/6/24	2014/6/24	2013/12/20

Performance criteria:

- 1 All system functions must be checked with appropriate testing programs and should pass the inspection.
- 2 There should be no abnormalities, which couldn't affect the product specified functions and performances.

Test result :

There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.



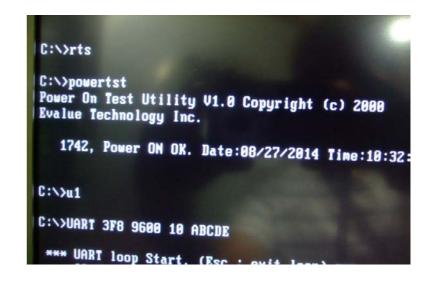


```
Display

STOP (FULL)

Count= 1742
6AcOn= 25.0
Timer= 16.4

SUB
```



## Storage test

**DMR Task Number** 

版本

T25597-00

Α1

Test Engineer	Max Chen Date	2014/8/29	Result	Pass
Test Configuration				
Model name	VPC1040CD			
Description	10.4" Fanless Multifunctional Touch	Panel Computer		
Hardware PCB version	EBM-BYT A1			
BIOS version	LPC12919.BIN			
CPU Type	Intel® Atom™ Processor E3845 (2M 0	Cache, 1.91 GHz)		
Memory type and size	Transcend DDR3L 1600 4GB TS512M	ISK64W6H-I		
Backplane	N/A			
Power(or Adapter)	FSP FSP060-DBAE1 12V/5A 60W Ada	pter		
HDD Model/Spec	PLEXTOR PW64G-5S 64GB 2.5" SSD			
CD-ROM Model/Spec	N/A			

Storage Test

Test Standard: Reference IEC60068-2-3 High temperature & Humidity storage test Test: Ca

Reference IEC60068-2-1 Cold test Test: Ab

Test Condition : Condition

Low temperature setup

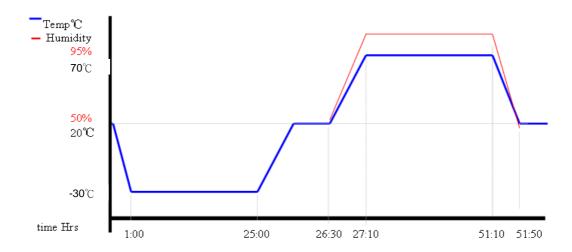
1 Test temperature : -30 $^{\circ}$ C (if system has LCD panel,storage temperature depend on panel spec.)

2 Test time: 24 hours

3 Temperature gradient 1°C/minute

High temperature setup  $1 \text{ Test temperature}: 70^{\circ}\text{C}$  2 Test humidity: RH 95% 3 Test time: 24 hours

4 Temperature gradient 1°C/minute



Test equipment :

### Programmable temperature & humidity chamber

	•	•		
use chamber		V		
Model:	Ten Billion FX1004	THS-D4T-150	THS-D4T-150+LN2	KSON THS-A4T-100
Date of calibration	2013/12/20	2014/6/24	2014/6/24	2013/12/20

Performance criteria :

- 1 All system functions must be checked with appropriate testing programs and should pass the inspection.
- 2 There should be no abnormalities, which couldn't affect the product specified functions and performances.

Test result : There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.







## **Random Vibration Operation**

**DMR Task Number** 

版本

T25597-00

Test Engineer	Max Chen	Date	2014/8/30	Result	Pass
Test Configuration					
Model name	VPC1040CD				
Description	10.4" Fanless Multi	functional Touch F	anel Computer		
Hardware PCB version	EBM-BYT A1				
BIOS version	LPC129I9.BIN				
CPU Type	Intel® Atom™ Proc	essor E3845 (2M C	ache, 1.91 GHz)		
Memory type and size	Transcend DDR3L	1600 4GB TS512M	SK64W6H-I		
Backplane	N/A				
Power(or Adapter)	FSP FSP060-DBAE	1 12V/5A 60W Adap	oter		
HDD Model/Spec	PLEXTOR PW64G-5	5S 64GB 2.5" SSD			
CD-ROM Model/Spec	N/A				

#### Random Vibration Operation

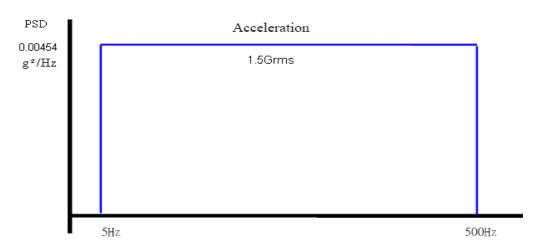
Test Standard: Reference IEC60068-2-64 Testing procedures

Test Fh: Vibration boardband random Test

Test Condition: 1 Test PSD: 0.00454G²/Hz, 1.5 Grms

2 Test frequency: 5~500 Hz
3 Test axis: X,Y and Z axis
4 Test time: 30 minutes each axis
5 System condition: operation mode

6 Test curve



Test equipment: Vibration simulator system

Model: VS-300VH

Date of calibration: 2014/8/18

Performance criteria: 1 All system functions must be checked with appropriate testing programs and should pass the inspection

2 There should be no abnormalities, which couldn't affect the product specified functions and performances

3 The cover and connectors should work properly without any interference

4 All screws should be tightened up appropriately

5 All gaps on the surface are appropriately

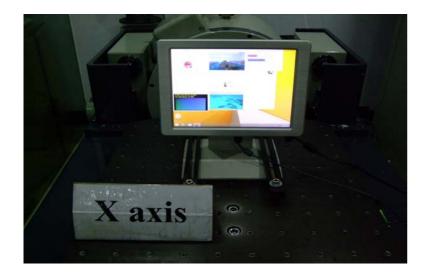
6 The assembling / disassembling of the system enclosure must be smooth and no deformed parts should be found

A1

Test result : There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.













## **Sine Vibration test (Non-operation)**

**DMR Task Number** 

T25597-00

			版本	. A1
Test Engineer	Max Chen Date	2014/8/30	Result	Pass
Test Configuration				
Model name	VPC1040CD			
Description	10.4" Fanless Multifunctional Toucl	n Panel Computer		
Hardware PCB version	EBM-BYT A1			
BIOS version	LPC129I9.BIN			
CPU Type	Intel® Atom™ Processor E3845 (2M	l Cache, 1.91 GHz)		
Memory type and size	Transcend DDR3L 1600 4GB TS512	MSK64W6H-I		
Backplane	N/A			
Power(or Adapter)	FSP FSP060-DBAE1 12V/5A 60W Ac	lapter		
HDD Model/Spec	PLEXTOR PW64G-5S 64GB 2.5" SS	D		
CD-ROM Model/Spec	N/A			

#### Random Vibration Operation

Test Standard: Reference IEC60068-2-6 Testing procedures

Test Fc: Vibration sinusoidal

Test Condition: 1 Test Acceleration: 2G

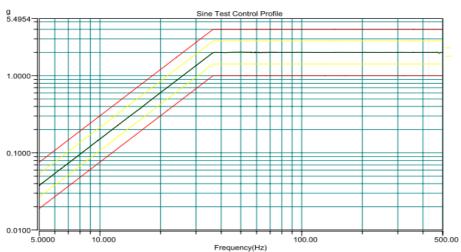
2 Test frequency: 5~500 Hz

3 Sweep: 1 Oct/ per one minute. (logarithmic)

4 Test axis : X,Y and Z axis 5 Test time :10 min. each axis

6 System condition: Non-Operating mode

7 Test curve



Test equipment :

Vibration simulator system

Model: VS-300VH

Date of calibration: 2014/8/18

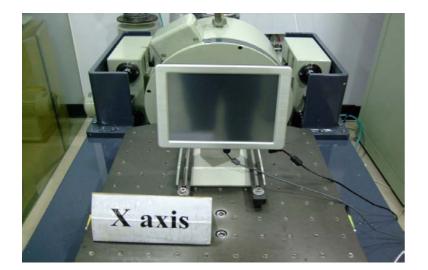
Performance criteria:

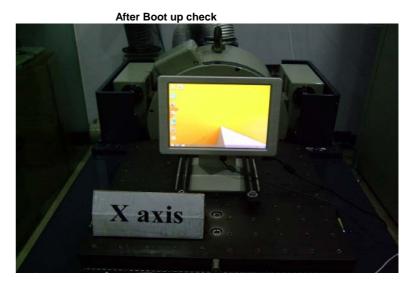
- 1 All system functions must be checked with appropriate testing programs and should pass the inspection
- 2 There should be no abnormalities, which couldn't affect the product specified functions and performances
- 3 The cover and connectors should work properly without any interference
- 4 All screws should be tightened up appropriately
- 5 All gaps on the surface are appropriately
- $6 \ The \ assembling \ / \ disassembling \ of \ the \ system \ enclosure \ must \ be \ smooth \ and \ no \ deformed \ parts \ should \ be \ found$

Test result : There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.













# Package vibration test

**DMR Task Number** 

版太

T25597-00

Α1

				////	T-1				
Test Engineer	Max Chen	Date	2014/8/30	Result	Pass				
Test Configuration									
Model name	VPC1040CD								
Description	10.4" Fanless Mul	10.4" Fanless Multifunctional Touch Panel Computer							
Hardware PCB version	EBM-BYT A1	EBM-BYT A1							
BIOS version	LPC12919.BIN	LPC129I9.BIN							
CPU Type	Intel® Atom™ Pro	cessor E3845 (2	M Cache, 1.91 GHz)						
Memory type and size	Transcend DDR3	L 1600 4GB TS5	12MSK64W6H-I						
Backplane	N/A								
Power(or Adapter)	FSP FSP060-DBA	E1 12V/5A 60W A	Adapter						
HDD Model/Spec	PLEXTOR PW64G	6-5S 64GB 2.5" S	SD						
CD-ROM Model/Spec	N/A								

Package Vibration Test

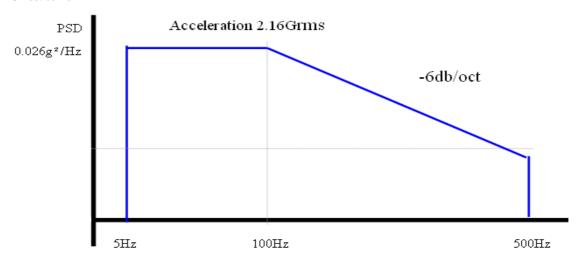
Test Standard: Reference IEC60068-2-64 Testing procedures

Test Fh: Vibration boardband random Test

Test Condition: 1 Test PSD: 0.026G<sup>2</sup>/Hz, 2.16 Grms

2 Test frequency: 5~500 Hz 3 Test axis: X,Y and Z axis 4 Test time: 30 minutes each axis

5 Test curve



Test equipment : Vibration simulator system

Model: VS-300VH

Date of calibration: 2014/8/18

Performance criteria:

- 1 All system functions must be checked with appropriate testing programs and should pass the inspection
- 2 There should be no abnormalities, which couldn't affect the product specified functions and performances
- 3 The cover and connectors should work properly without any interference
- 4 All screws should be tightened up appropriately
- 5 All gaps on the surface are appropriately
- 6 The assembling / disassembling of the system enclosure must be smooth and no deformed parts should be found

Test result : There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.

Test picture :







After Boot up check





DMR Task Number

T25597-00

版本 A1

Test Engineer	Max Chen	Date	2014/8/30	Result	Pass				
Test Configuration									
Model name	VPC1040CD								
Description	10.4" Fanless Multifunctional Touch Panel Computer								
Hardware PCB version	EBM-BYT A1								
BIOS version	LPC129I9.BIN								
CPU Type	Intel® Atom™ Proce	essor E3845 (2M	Cache, 1.91 GHz)						
Memory type and size	Transcend DDR3L 1	1600 4GB TS512I	MSK64W6H-I						
Backplane	N/A								
Power(or Adapter)	FSP FSP060-DBAE1	12V/5A 60W Ada	apter						
HDD Model/Spec	PLEXTOR PW64G-5S 64GB 2.5" SSD								
CD-ROM Model/Spec	N/A								

Test Standard: Reference IEC 60068-2-29 Testing procedures

Test Eb: Bump Test

Test Condition: Wave form: Half Sine wave

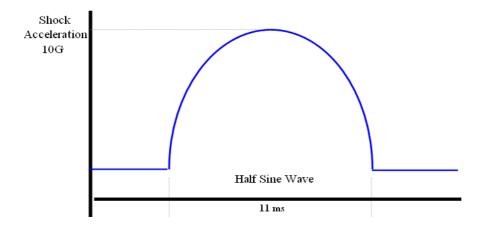
Acceleration Rate: 10g Duration Time: 11ms

No. of Shock: Z axis 1000 times

Test Axis: Z axis

System condition: operation (running burn in test program)

Test curve :



Test equipment : Shock tester

Model: VS-300VH

Date of calibration: 2014/8/18

Performance criteria :

- 1 All system functions must be checked with appropriate testing programs and should pass the inspection
- 2 There should be no abnormalities, which couldn't affect the product specified functions and performances
- 3 The cover and connectors should work properly without any interference
- 4 All screws should be tightened up appropriately
- 5 All gaps on the surface are appropriately
- 6 The assembling / disassembling of the system enclosure must be smooth and no deformed parts should be found

Test result: There is no damage in electronic and mechanical functions.

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.

### Test picture :





# **Package Drop Test**

**DMR Task Number** 

T25597-00

			版本	A1				
Test Engineer	Max Chen Date	2014/8/18	Result	Pass				
Test Configuration								
Model name	VPC1040CD							
Description	10.4" Fanless Multifunctional Touch Pa	anel Computer						
Hardware PCB version	EBM-BYT A1	EBM-BYT A1						
BIOS version	LPC129I9.BIN							
CPU Type	Intel® Atom™ Processor E3845 (2M Ca	ache, 1.91 GHz)						
Memory type and size	Transcend DDR3L 1600 4GB TS512MS	SK64W6H-I						
Backplane	N/A							
Power(or Adapter)	FSP FSP060-DBAE1 12V/5A 60W Adap	ter						
HDD Model/Spec	PLEXTOR PW64G-5S 64GB 2.5" SSD							
CD-ROM Model/Spec	N/A							

Package Drop Test

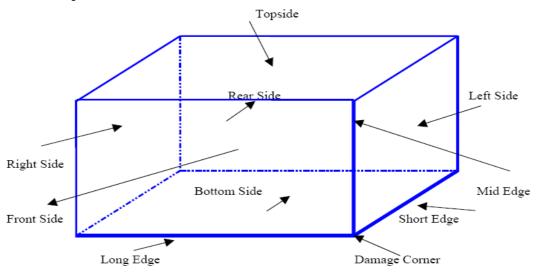
Test Standard: Reference ISTA 2A, Method: IEC-60068-2-32 Test:Ed

Test Ea: Drop Test

Test Condition: 1 Test phase : One corner, three edges, six faces

> 2 Test high: 96.5 cm 3 Package weight: 3.87 kg

4 Test drawing



Test equipment: Drop test machine

> J.T.M Tech. Model: JTM-1775

Performance criteria: 1 All system functions must be checked with appropriate testing programs and should pass the inspection

2 There should be no abnormalities, which couldn't affect the product specified functions and performances

3 The cover and connectors should work properly without any interference

4 All screws should be tightened up appropriately

5 All gaps on the surface are appropriately

6 The assembling / disassembling of the system enclosure must be smooth and no deformed parts should be found

There is no damage in electronic and mechanical functions. Test result:

Degradation has no been found.

Performance is maintained with no incurable physical damage or degradation.

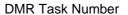
### Test picture :





After Boot up check





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T25597-00

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Test Engineer	Max Chen Date	2014/9/1	Result	Pass						
Model	VPC1040CD									
Description	10.4" Fanless Multifunctional Touch Panel C	0.4" Fanless Multifunctional Touch Panel Computer								
PCB version	EBM-BYT A1	BM-BYT A1								
BIOS version	LPC129I9.BIN	_PC129I9.BIN								
CPU Type	Intel® Atom™ Processor E3845 (2M Cache, 1	I.91 GHz)								
Memory type and size	Transcend DDR3L 1600 4GB TS512MSK64W	/6H-I								
Backplane	N/A									
Power(or Adapter)	FSP FSP060-DBAE1 12V/5A 60W Adapter									
HDD Model/Spec	PLEXTOR PW64G-5S 64GB 2.5" SSD	PLEXTOR PW64G-5S 64GB 2.5" SSD								
CD-ROM Model/Spec	N/A									

Purpose: To evaluate whether the functions are maintained in a stable condition after the product is implement misuse test.

Conditions: Perform all types of misuses including the following which could take place in operation.

- 1) Simultaneous operation
- 2) Opposite operation
- 3) Halfway operation
- 4) Incomplete operation
- 5) Procedure omission
- 6) Wrong procedure

#### Test Procedure:

**Misuse Test** 

### 1 Simultaneous operation

- 1-1 Turn on the system and press any two keys simultaneous until system into OS.
- 1-2 Turn on the system and press mouse right and left keys simultaneous until system into OS.
- 1-3 Turn on the system and press touch panel simultaneous until system into OS.

#### 2 Opposite operation

- 2-1 PS/2 keyboard connector connect with PS/2 mouse then power on and boot into the OS.
- 2-2 PS/2 mouse connector connect with PS/2 keyboard then power on and boot into the OS.
- 2-3 Audio line out connector connect with MIC then turn on system and play music file.
- 2-4 Cash drawer cable RJ11 connect to RJ45 connector then power on and boot into the OS.

#### 3 Halfway

- 3-1 Directly turn off power at system starting boot up into OS.
- 3-2 Insert devices at system starting boot up.
- 3-3 Removed devices at system executing closing.

#### 4 Incomplete operation

- 4-1 Insert power cord to power supply socket incompletely then perform the on/off test.
- 4-2 Insert devices to specified connector incompletely then power on and boot into OS.

#### 5 Procedure omission

- 5-1 Directly power off without OS shutdown rule.
- 5-2 Adapter with DC output then directly plug to system DC jack and boot up system ten times.

#### 6 Wrong procedure

- 6-1 System mode is S5 then press and hold push button until system stop operation.
- 6-2 System mode is S0 then press and hold push button until system stop operation.

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## Judgment Criteria:

The product shall operate normally and no any damage after the test.

Item	sub-Item	Device	Manufacture /PN	Test stage	Result	Note/Issue ID
	1-1	Keyboard		DVT	NA	
Simultaneous operation	1-2	Mouse		DVT	NA	
	1-3	Touch		DVT	Pass	
	2-1	Mouse		DVT	NA	
Opposite operation	2-2	Keyboard		DVT	NA	
	2-3	Audio		DVT	Pass	
	2-4	RJ45	RJ11 cable	DVT	Pass	
Halfway	3-1			DVT	Pass	
·	3-2	USB Key/Mous		DVT	Pass	
	3-3	USB Key/Mous		DVT	Pass	
Incomplete operation	4-1			DVT	Pass	
	4-2	USB Key/Mous		DVT	Pass	
	5-1			DVT	Pass	
Procedure omission		12V		DVT	Pass	
Flocedure offission	5-2	19V		DVT	Pass	
		24V		DVT	Pass	
\\/\rangle	6-1			DVT	Pass	
Wrong procedure	6-2			DVT	Pass	



**DMR Task Number** 

T25597-00

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Test Engineer	Max Chen Date	2014/9/1	Result	Pass					
Model	VPC1040CD								
Description	10.4" Fanless Multifunctional Touch Panel C	Computer							
PCB version	EBM-BYT A1								
BIOS version	LPC129I9.BIN	LPC129I9.BIN							
CPU Type	Intel® Atom™ Processor E3845 (2M Cache,	1.91 GHz)							
Memory type and size	Transcend DDR3L 1600 4GB TS512MSK64V	V6H-I							
Backplane	N/A								
Power(or Adapter)	FSP FSP060-DBAE1 12V/5A 60W Adapter								
HDD Model/Spec	PLEXTOR PW64G-5S 64GB 2.5" SSD								
CD-ROM Model/Spec	N/A								

Purpose: To check that there is no risk of fire or electric shock in abnormal situations caused by the failure

of an internal component of the product.

Conditions: Environment : 25°C ± 2°C ambient Humidity : 60 ± 10% RH

#### Test Procedure:

1 Adjust the serial port DC output to +5V by jumper cap.

- 2 Turn on the test item and startup into the OS win8.1
- 3 Perform the short test +5V to GND
- 4 Adjust the serial port DC output to +12V by jumper cap, then repeat step 2 and 3.
- 5 Turn on the test item and startup into the OS Win8.1
- 6 Perform the USB port short test (VCC to GND)
- 7 Turn on the test item and startup into the OS
- 8 Perform the PS/2 ports short test (VCC to GND)
- 9 Turn on the test item and startup into the OS Win8.1
- 10 Turn on the test item and startup into the OS Win8.1
- 11 Perform the DC IN short test. (DC IN power supply only)
- 12 Perform the ATX power short test (ATX Power support)

### Judgment Criteria:

- 1 There must be no danger of fire.
- 2 It must not catch fire.
- 3 It must not produce smoke. (If the product is equipped with a protective device, smoke is allowed in an amount not exceeding that produced by the burning end of a cigarette for 10 seconds.)
- 4 Solder must not have been melted by heating of components.
- 5 The case must not deform from the generated heat.
- 6 The product must not present a danger of electric shock.

Test item	Nunber	Result ststement	Test stage	Result	Note/Issue ID
Serial port	COM1	System Shutdown	DVT	Pass	
USB port	USB1	No any damage	DVT	Pass	
	USB2	No any damage	DVT	Pass	
PS/2	Keyboard		DVT	NA	
	Mouse		DVT	NA	
	12 V	System Shutdown	DVT	Pass	
DC IN	19 V	System Shutdown	DVT	Pass	
	24 V	System Shutdown	DVT	Pass	

# Thermal and Capacitor Life time Calculation

DMR Task Number

T25597-00

版本

Α1

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Test Engineer	Max Chen	Date	2014/8/19	Result	Pass					
Test Configuration										
Model name	VPC1040CD									
Description	10.4" Fanless Multifund	ctional Touch Panel (	Computer							
Hardware PCB version	EBM-BYT A1									
BIOS version	LPC129I9.BIN	PC129I9.BIN								
CPU Type	Intel® Atom™ Process	Intel® Atom™ Processor E3845 (2M Cache, 1.91 GHz)								
Memory type and size	Transcend DDR3L 160	0 4GB TS512MSK64V	V6H-I							
Backplane	N/A									
Power(or Adapter)	FSP FSP060-DBAE1 12	V/5A 60W Adapter								
HDD Model/Spec	Innodisk Evergreen SS	D 16GB								
CD-ROM Model/Spec	N/A									
os	Windows 8.1									
Test software	Burn in Test V7.0 + Kpc	ower x 4 + Ping LAN -	+ COM Stress							

 $Lx = Lo \times 2^{(To - Tx)/10} \times 2^{(\Delta To - \Delta Tx)/5}$ = Lo  $\times 2^{(105 - Tx)/10} \times 2^{(5 - \Delta Tx)/5}$ 

Lifetime (hours) of the capacitor to be estimated

Base lifetime (hours) of the capacitor described in the specification sheet

To = Maximum rated operating temperature

= Actual ambient temperature (°C) of the capacitor within device (This is not the environment temperature of the device, but the environment temperature of the capacitor that has been placed within the device.)

ΔTo = Rise (°C) in core temperature of the capacitor due to rated (permissible)

maximum ripple current.

Life Time Estimation Formula on PX/PXA/PS/PSA series Capacitors

 $Lx = Lo \times 10^{(To - Tx)/20}$ =  $2000 \times 10^{(105 - Tx)/20}$ 

Where: Lx = Lifetime (hours) of the capacitor to be estimated Lo = Base lifetime (hours) of the capacitor described in the specification sheet;

base ineume (nours) of the capacitor described in the specification sneet; 2000hours for PX/PXA/PS/PSA series

Maximum rated operating temperature; 105°C for PX/PXA/PS/PSA series Actual ambient temperature (°C) of the capacitor within device (This is not the environment temperature of the device, but the environment temperature of the device, but the device.)

Test procedure:

- 1. Room Temperature Thermal and Capacitor Life time Calculation & battery , Panel , Inverter or Converter
- 2. Product Spec Temperature Thermal and Capacitor Life time Calculation & battery , Panel , Inverter or Converter

#### Measure in chamber **25**℃

Chamber	aluminum	aluminum	aluminum	aluminum	aluminum	aluminum		
<b>25</b> ℃	EC1	EC2	EC3	EC4	C279	EC5		
Ts(°ℂ)	50.40	53.70	51.40	52.20	49.70	47.90		
Tx(°C)								
Lo(hours)	2000	5000	5000	5000	5000	5000		
Kc								
<b>ΔTx</b> (°ℂ)								
Lx(hours)	1074064	1836412	2393150	2182579	2910516	3580717		
Life(years)	122.61	209.64	273.19	249.15	332.25	408.76		
Result	Pass	Pass	Pass	Pass	Pass	Pass		

 $\Delta Tx = (Ts - Tx) x Kc$ 

Ts = Surface temperature (°C) of the case Where:

Tx = Actual ambient temperature (°C) of the capacitor

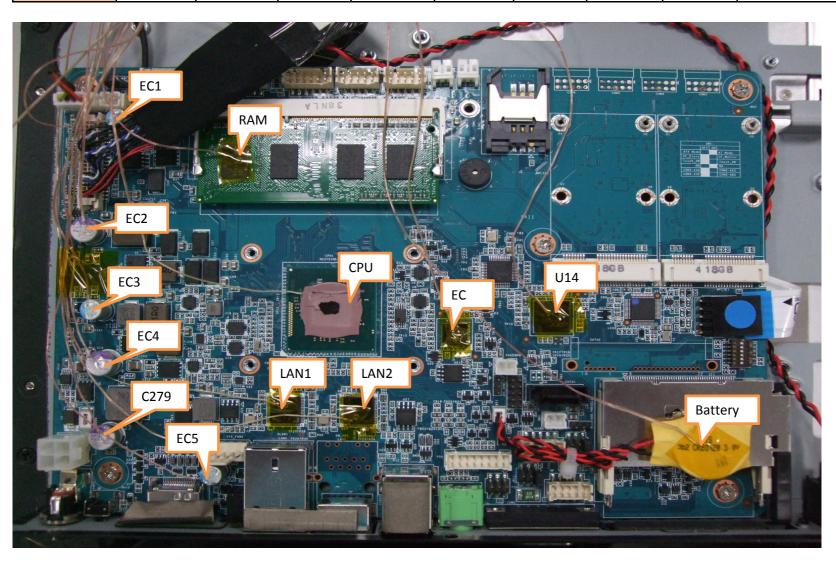
Coefficient standing for the ratio of the  $\Delta Tx$  to the (Ts - Tx)

For the Kc's, refer to the table below:

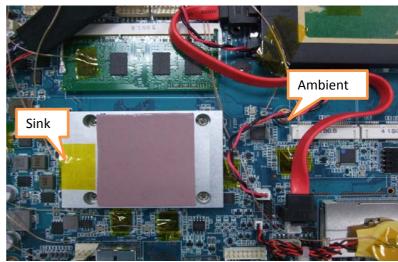
diameter (mm) | \$6-\$ \$6 | \$10 | \$12.5 | \$616 φ18 1.10 1.15 1.20 1.25 1.30

Chamber	CPU	LAN1	LAN2	Audio	Memory	EC ITE		
<b>25</b> ℃	E3845	I210-IT	I210-IT	ALC 892		IT8528VG		
SPEC	110.00	105.00	105.00	105.00	95.00	85.00		
Ts	47.30	55.70	50.50	59.30	52.90	51.40		
SPEC - Ts	62.70	49.30	54.50	45.70	42.10	33.60		
Result	Pass	Pass	Pass	Pass	Pass	Pass		

Chamber	Battery	Panel	SSD	U14	Ambient		
<b>25</b> ℃							
SPEC(Ta)	80.00	80.00	85.00				
Ts	42.90	50.40	43.80	64.40	40.20		











# Thermal and Capacitor Life time Calculation

**DMR Task Number** 

T25597-00

Α1

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Test Engineer	Max Chen	Date	2014/8/19	Result	Pass					
Test Configuration										
Model name	VPC1040CD									
Description	10.4" Fanless Multifuncti	ional Touch Pane	l Computer							
Hardware PCB version	EBM-BYT A1									
BIOS version	LPC129I9.BIN	LPC129I9.BIN								
CPU Type	Intel® Atom™ Processor	E3845 (2M Cach	e, 1.91 GHz)							
Memory type and size	Transcend DDR3L 1600	4GB TS512MSK6	4W6H-I							
Backplane	N/A									
Power(or Adapter)	FSP FSP060-DBAE1 12V	5A 60W Adapter								
HDD Model/Spec	Innodisk Evergreen SSD	16GB								
CD-ROM Model/Spec	N/A									
OS	Windows 8.1									
Test software	Burn in Test V7.0 + Kpov	ver x 4 + Ping LA	N + COM Stress							

 $\Delta Tx = (Ts - Tx) x Kc$ 

Ts = Surface temperature (°C) of the case

Tx = Actual ambient temperature (°C) of the capacitor

For the Kc's, refer to the table below:

Coefficient standing for the ratio of the  $\Delta Tx$  to the (Ts - Tx)

1.10 1.15 1.20 1.25

diameter (mm) | \$6-\$ \$6 | \$10 | \$12.5 | \$616

Where:

 $Lx = Lo \times 2^{(To - Tx)/10} \times 2^{(\Delta To - \Delta Tx)/5}$ = Lo  $\times 2^{(105 - Tx)/10} \times 2^{(5 - \Delta Tx)/5}$ 

= Lifetime (hours) of the capacitor to be estimated

Base lifetime (hours) of the capacitor described in the specification sheet

To = Maximum rated operating temperature

Tx = Actual ambient temperature (°C) of the capacitor within device (This is not the environment temperature of the device, but the environment

temperature of the capacitor that has been placed within the device.) ΔTo = Rise (°C) in core temperature of the capacitor due to rated (permissible)

maximum ripple current.

Life Time Estimation Formula on PX/PXA/PS/PSA series Capacitors

 $Lx = Lo \times 10^{(To - Tx)/20}$ =  $2000 \times 10^{(105 - Tx)/20}$ 

Where: Lx = Lifetime (hours) of the capacitor to be estimated Lo = Base lifetime (hours) of the capacitor described in the specification sheet; 2000hours for PX/PXA/PS/PSA series

Maximum rated operating temperature; 105°C for PX/PXA/PS/PSA series

Actual ambient temperature (°C) of the capacitor within device (This is not the environment temperature of the device, but the environment temperature of the device, but the device.)

Test procedure:

- 1. Room Temperature Thermal and Capacitor Life time Calculation & battery , Panel , Inverter or Converter
- 2. Product Spec Temperature Thermal and Capacitor Life time Calculation & battery , Panel , Inverter or Converter

#### Measure in chamber **70**℃

Chamber	aluminum	aluminum	aluminum	aluminum	aluminum	aluminum		
<b>70</b> ℃	EC1	EC2	EC3	EC4	C279	EC5		
Ts(°ℂ)	81.60	88.90	86.30	87.70	84.40	85.50		
Tx(°C)								
Lo(hours)	2000	5000	5000	5000	5000	5000		
Kc								
<b>ΔTx(</b> °ℂ)								
Lx(hours)	29582	31913	43050	36641	53576	47203		
Life(years)	3.38	3.64	4.91	4.18	6.12	5.39		
Result	Pass	Pass	Pass	Pass	Pass	Pass		

Chamber	CPU	LAN1	LAN2	Audio	Memory	EC ITE		
<b>70</b> ℃	E3845	I210-IT	I210-IT	ALC 892		IT8528VG		
SPEC	110.00	105.00	105.00	105.00	95.00	85.00		
Ts	85.40	92.70	87.50	95.10	89.70	85.00		
SPEC - Ts	24.60	12.30	17.50	9.90	5.30	0.00		
Result	Pass	Pass	Pass	Pass	Pass	Pass		

Chamber	Battery	Panel	SSD	U14	Ambient		
<b>70</b> ℃							
SPEC(Ta)	80.00	80.00	85.00				
Ts	78.60	83.00	80.90	97.30	79.00		

